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Twin Build in Biasing Circuit MOS FET IC VHF/UHF RF Amplifier



ADE-208-1599 (Z)

Rev.0 Jun. 2002

Features

- Small SMD package CMPAK-6 built in twin BBFET; To reduce using parts cost & PC board space.
- Suitable for World Standard Tuner RF amplifier.
- Very useful for total tuner cost reduction.
- Withstanding to ESD; Build in ESD absorbing diode. Withstand up to 200 V at C = 200 pF, Rs = 0 conditions.
- Provide mini mold packages; CMPAK-6

Outline

CMPAK-6



- 1. Gate-1(1)
- 2. Source
- 3. Drain(1)
- 4. Drain(2)
- 5. Gate-2
- 6. Gate-1(2)

Notes: 1. Marking is "HM".

2. TBB1008 is individual type number of HITACHI TWIN BBFET.

Absolute Maximum Ratings

 $(Ta = 25^{\circ}C)$

Item	Symbol	Ratings	Unit	
Drain to source voltage	V _{DS}	6	V	
Gate1 to source voltage	$V_{\scriptscriptstyle G1S}$	+6 -0	V	
Gate2 to source voltage	V _{G2S}	+6 -0	V	
Drain current	I _D	30	mA	
Channel power dissipation	Pch ^{*3}	250	mW	
Channel temperature	Tch	150	°C	
Storage temperature	Tstg	-55 to +150	°C	

Notes: 3. Value on the glass epoxy board (50 mm \times 40 mm \times 1 mm).



Electrical Characteristics

The below specification are applicable for UHF unit (FET1)

 $(Ta = 25^{\circ}C)$

Item	Symbol	Min	Тур	Max	Unit	Test Conditions
Drain to source breakdown voltage	$V_{(BR)DSS}$	6	_	_	V	$I_{_{D}} = 200 \ \mu A, \ V_{_{G1S}} = V_{_{G2S}} = 0$
Gate1 to source breakdown voltage	V _{(BR)G1SS}	+6	_	_	V	$I_{G1} = +10 \mu A, V_{G2S} = V_{DS} = 0$
Gate2 to source breakdown voltage	V _{(BR)G2SS}	+6	_	_	V	$I_{G2} = +10 \mu A, V_{G1S} = V_{DS} = 0$
Gate1 to source cutoff current	I _{G1SS}	_	_	+100	nA	$V_{G1S} = +5 \text{ V}, V_{G2S} = V_{DS} = 0$
Gate2 to source cutoff current	I _{G2SS}		_	+100	nA	$V_{G2S} = +5 \text{ V}, V_{G1S} = V_{DS} = 0$
Gate1 to source cutoff voltage	V _{G1S(off)}	0.5	0.7	1.0	V	$V_{DS} = 5 \text{ V}, V_{G2S} = 4 \text{ V}, I_{D} = 100 \mu\text{A}$
Gate2 to source cutoff voltage		0.5	0.7	1.0	V	$V_{DS} = 5 \text{ V}, V_{G1S} = 5 \text{ V}, I_{D} = 100 \mu\text{A}$
Drain current	D(op)	13	17	21	mA	$V_{DS} = 5 \text{ V}, V_{G1} = 5 \text{ V}$ $V_{G2S} = 4 \text{ V}, R_{G} = 100 \text{ k}\Omega$
Forward transfer admittance	ly _{fs} l	21	26	32	mS	$V_{DS} = 5 \text{ V}, V_{G1} = 5 \text{ V}, V_{G2S} = 4 \text{ V}$ $R_{G} = 100 \text{ k}\Omega, f = 1 \text{ kHz}$
Input capacitance	Ciss	1.4	1.8	2.2	pF	$V_{DS} = 5 \text{ V}, V_{G1} = 5 \text{ V}$
Output capacitance	Coss	1.0	1.4	1.8	pF	V_{G2S} =4 V, R_{G} = 100 k Ω
Reverse transfer capacitance	Crss	_	0.02	0.04	pF	f = 1 MHz
Power gain	PG	16	21		dB	$V_{_{DS}} = V_{_{G1}} = 5 \text{ V}, V_{_{G2S}} = 4 \text{ V}$ $R_{_{G}} = 100 \text{ k}\Omega, f = 900 \text{ MHz}$ $Zi = S11^*, Zo = S22^* \text{ (:PG)}$
Noise figure	NF	_	1.7	2.5	dB	Zi = S11opt (:NF)
					C	

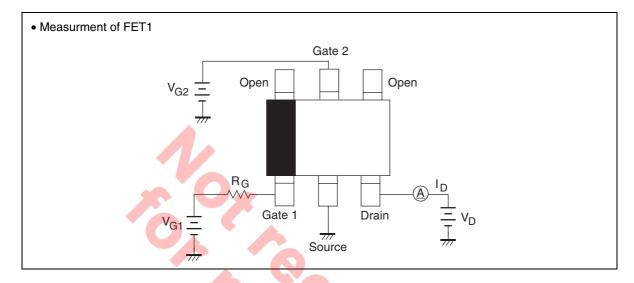
The below specification are applicable for VHF unit (FET2)

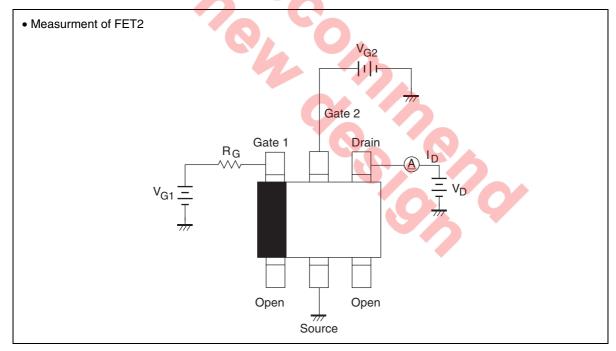
 $(Ta = 25^{\circ}C)$

Item	Symbol	Min	Тур	Max	Unit	Test Conditions
Drain to source breakdown voltage	$V_{(BR)DSS}$	6	_	_	V	$I_D = 200 \mu\text{A}, V_{G1S} = V_{G2S} = 0$
Gate1 to source breakdown voltage	$V_{\text{(BR)G1SS}}$	+6	_	_	V	$I_{G1} = +10 \mu A, V_{G2S} = V_{DS} = 0$
Gate2 to source breakdown voltage	V _{(BR)G2SS}	+6	_	_	V	$I_{G2} = +10 \mu A, V_{G1S} = V_{DS} = 0$
Gate1 to source cutoff current	I _{G1SS}	_	_	+100	nA	$V_{G1S} = +5 \text{ V}, V_{G2S} = V_{DS} = 0$
Gate2 to source cutoff current	I _{G2SS}	_	_	+100	nA	$V_{G2S} = +5 \text{ V}, V_{G1S} = V_{DS} = 0$
Gate1 to source cutoff voltage	V _{G1S(off)}	0.5	0.75	1.0	V	$V_{DS} = 5 \text{ V}, V_{G2S} = 4 \text{ V}, I_{D} = 100 \mu\text{A}$
Gate2 to source cutoff voltage	V _{G2S(off)}	0.5	0.75	1.0	V	$V_{DS} = 5 \text{ V}, V_{G1S} = 5 \text{ V}, I_{D} = 100 \mu\text{A}$
Drain current	D(op)	16	20	24	mA	$V_{DS} = 5 \text{ V}, V_{G1} = 5 \text{ V}, V_{G2S} = 4 \text{ V}$ $R_{G} = 100 \text{ k}\Omega$
Forward transfer admittance	ly _{fs} l	27	32	38	mS	$V_{DS} = 5 \text{ V}, V_{G1} = 5 \text{ V}, V_{G2S} = 4 \text{ V}$ $R_{G} = 100 \text{ k}\Omega, f = 1 \text{ kHz}$
Input capacitance	Ciss	2.3	2.7	3.1	pF	V _{DS} = 5 V, V _{G1} = 5 V
Output capacitance	Coss	1.4	1.8	2.2	pF	$V_{G2S} = 4 \text{ V}, R_{G} = 100 \text{ k}\Omega$
Reverse transfer capacitance	Crss		0.03	0.05	pF	f = 1 MHz
Power gain	PG	24	29	+/	dB	$V_{DS} = V_{G1} = 5 \text{ V}, V_{G2S} = 4 \text{ V}$
Noise figure	NF	-	1.2	1.7	dB	$R_{\rm G} = 100 \text{ k}\Omega, f = 200 \text{ MHz}$
			Ç	Q		0

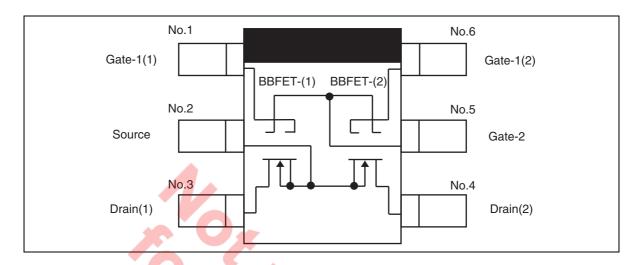
Test Circuits

 $\bullet \ \textbf{DC Biasing Circuit for Operating Characteristic Items} \ (I_{D(op)}, |yfs|, Ciss, Coss, Crss, NF, PG) \\$

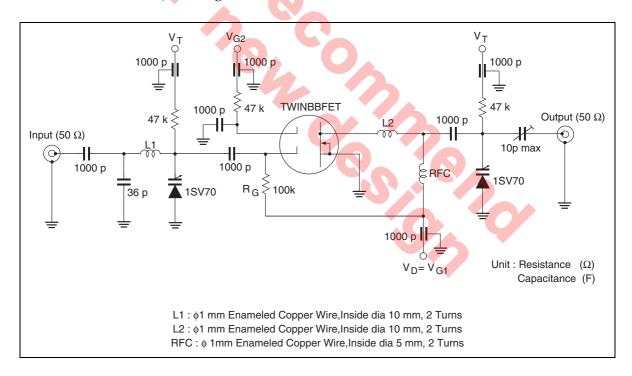




• Equivalent Circuit

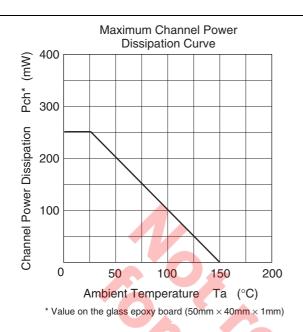


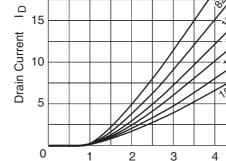
• 200 MHz Power Gain, Noise Figure Test Circuit



5

 V_{DS} (V)





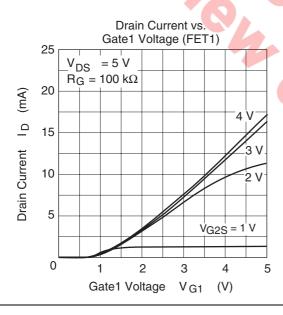
Drain to Source Voltage

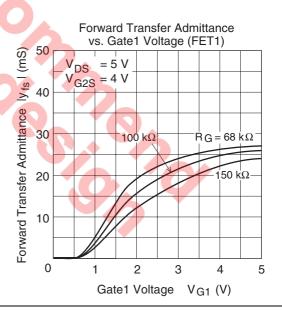
 $V_{G2S} = 4 V$ $V_{G1} = V_{DS}$

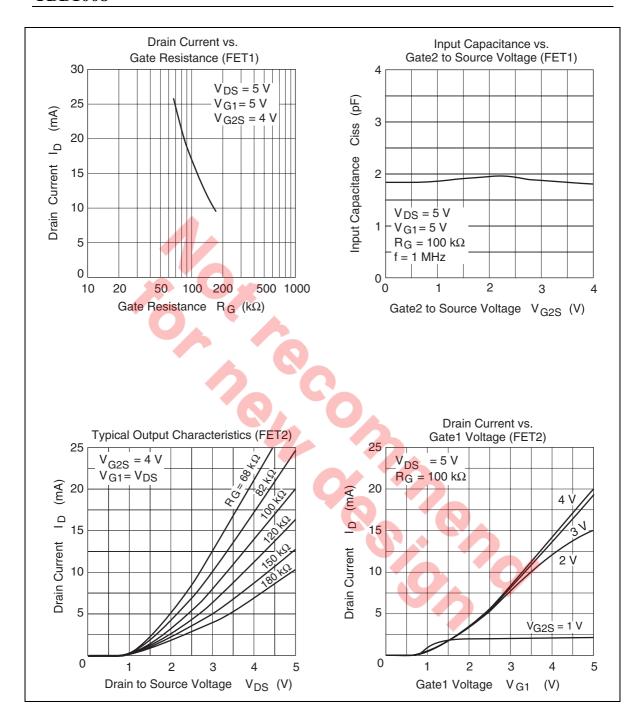
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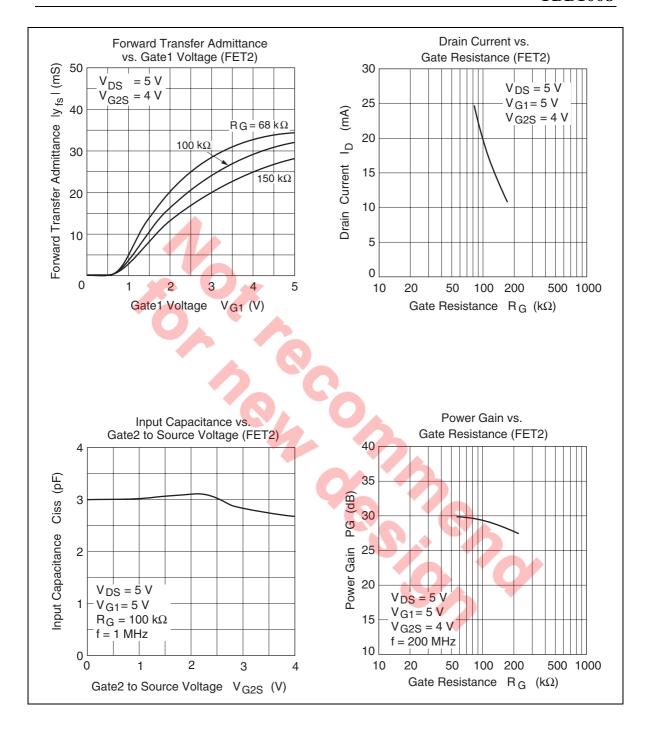
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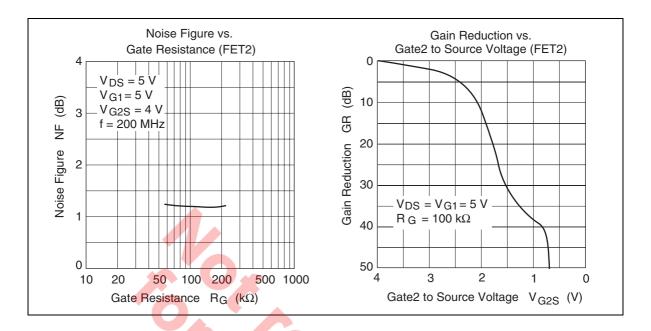
(mA) 20 Typical Output Characteristics (FET1)



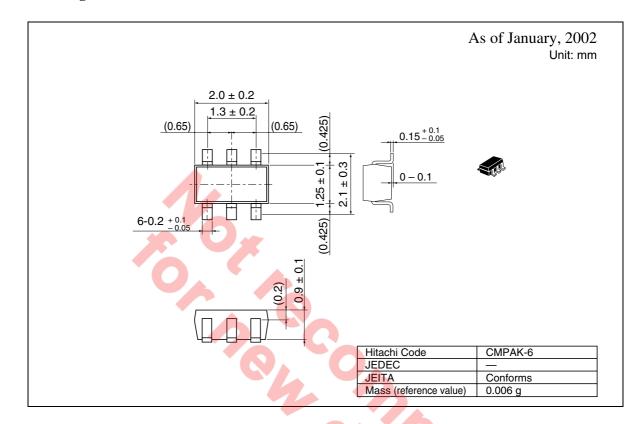








Package Dimensions



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